## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SCHEUCHER, HEIMO Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0211700	11-2003	Leung et al.	438/401
*	В	US-6,114,072	09-2000	Narimatsu, Koichiro	438/462
	С	US-		·	
	D	US-			
	E	US-		·	•
	F	US-			,
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	κ	US-			
	L	US-		·	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				•	
	Р			·		
	Q					i i
	R					
	s			•		
	Т					

## **NON-PATENT DOCUMENTS**

_	NON-FATENT DOCUMENTS						
*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
×	Ü						
	٧						
	w						
	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.